

Enhancement Mode N-Channel Power MOSFET

 $SOT23-3/NMOS/30V/\pm12V/0.9V/6.5A/17.2m\Omega$

Rev1.2





30V, 17.2m Ω , 6.5A, Single N-Channel

1.Features

- 30V MOSFET technology
- ◆ Low on-state resistance
- Fast switching
- ♦ Vgs±12V

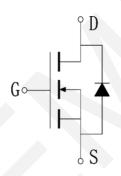
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- ◆ Power Switching Application
- Load Switching



Pin Description

V _{DS}	R _{DS(on)} Typ.	I _D Max.	
30V	17.2mΩ @ 10V		
	19mΩ @4.5V	6.5A	
	24mΩ @2.5V		



Schematic Diagram

3. Package Marking and Ordering Information

Part no.	Marking	Package	PCS/Reel	PCS/CTN.
WP3400CS3	*3400	SOT23-3	3,000	180,000

4.Absolute Max Ratings at Ta=25°C (Note1)

Parameter	Symbol	Maximum	Units
Drain to Source Voltage	$V_{ extsf{DSS}}$	30	V
Gate to Source Voltage	V_{GSS}	±12	٧
Drain Current (DC)	I _D	6.5	А
Drain Current (Pulse), PW≤300μs	I _{DP}	26	А
Total Dissipation	P_{D}	1.36	W
Junction Temperature	T _j	150	°C
Storage Temperature	T_{stg}	-55 to +150	°C

Note 1: Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.



5.Thermal Resistance Ratings (Note 2)

Parameter	Symbol	Value	Unit
Thermal Resistance, Junction-to-Ambient	$R_{ hetaJA}$	92	°C/W

Note 2: When mounted on 1 inch square copper board $t \le 10$ sec The value in any given application depends on the user's specific board design.

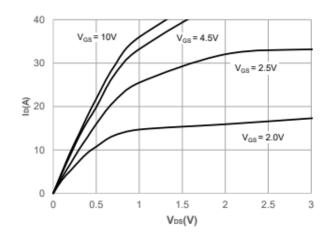
6.Electrical Characteristics at Ta=25°C (Note 3)

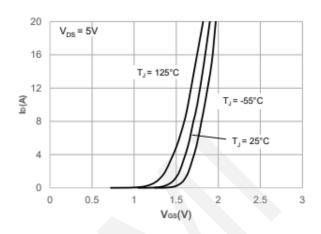
Parameter	Symbol	Test Conditions	Min.	Тур.	Max.	Units
Drain to Source Breakdown Voltage	V _{(BR)DSS}	$I_D = 250 \mu A, V_{GS} = 0 V$	30	33	-	V
Zero-Gate Voltage Drain Current	I _{DSS}	$V_{DS} = 30V, V_{GS} = 0V$	-	ı	1	μΑ
Gate to Source Leakage Current	I _{GSS}	$V_{GS} = \pm 12V, V_{DS} = 0V$	-	1	±100	nA
Gate Threshold Voltage	$V_{GS(th)}$	$V_{DS}=V_{GS}$, $I_{DS}=250\mu A$	0.5	0.9	1.5	V
		I _D = 5.5A, V _{GS} =10V	1	17.2	22	mΩ
Static Drain to Source On-State Resistance	R _{DS(on)}	I _D = 4.5A, V _{GS} = 4.5V	-	19	25	mΩ
reconstance		I _D = 3A, V _{GS} = 2.5V	-	24	35	mΩ
Input Capacitance	C _{iss}	V _{GS} =0V,		785	-	pF
Output Capacitance	C _{oss}	V _{DS} =15V,	-	66	-	pF
Reverse Transfer Capacitance	C _{rss}	Frequency=1.0MHz	-	54	-	pF
Turn-ON Delay Time	t _{d(on)}		-	4	-	ns
Rise Time	t _r	$V_{DS} = 15V, I_{D} = 3A$	-	11	-	ns
Turn-OFF Delay Time	$t_{d(off)}$	V_{GS} = 10V, R_G = 3 Ω	-	24	-	ns
Fall Time	t _f		-	2	-	ns
	Q_g	V _{DS} = 15V,	-	19	-	nC
Total Gate Charge	Q _{gs}	V _{GS} =10V,	-	2	-	nC
	Q_{gd}	I _D = 3A	-	2.1	-	nC
Diode Forward Voltage	V_{FSD}	I _S = 6.5A, V _{GS} = 0V	0.5	0.85	1.2	V

Note 3: Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

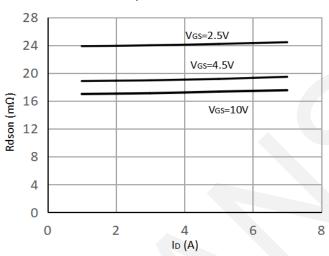


7. Typical Electrical and Thermal Characteristics

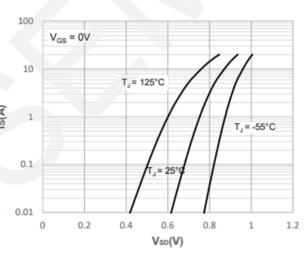




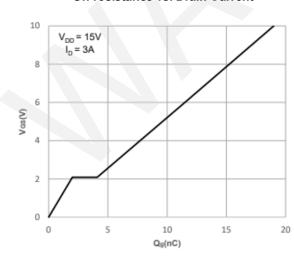
Output Characteristics



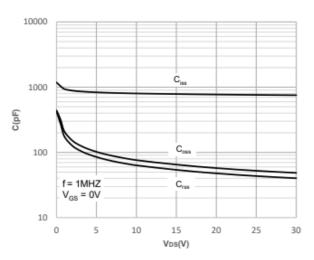
Typical Transfer Characteristics



On-resistance vs. Drain Current



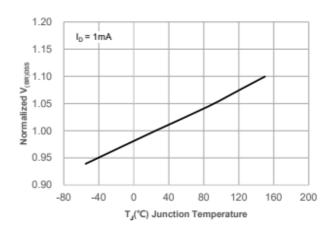
Body Diode Characteristics

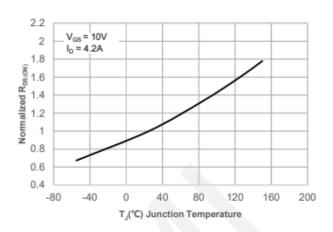


Gate Charge Characteristics

Capacitance Characteristics





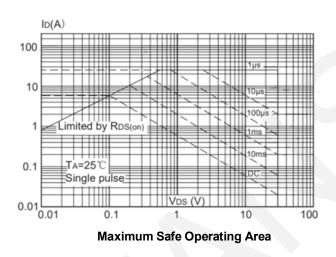


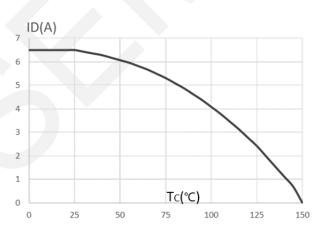
Normalized Breakdown Voltage vs.

Junction Temperature

Normalized on Resistance vs.

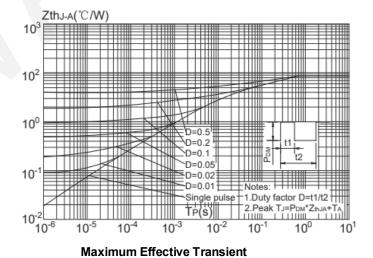
Junction Temperature





Maximum Continuous Drain Current vs.

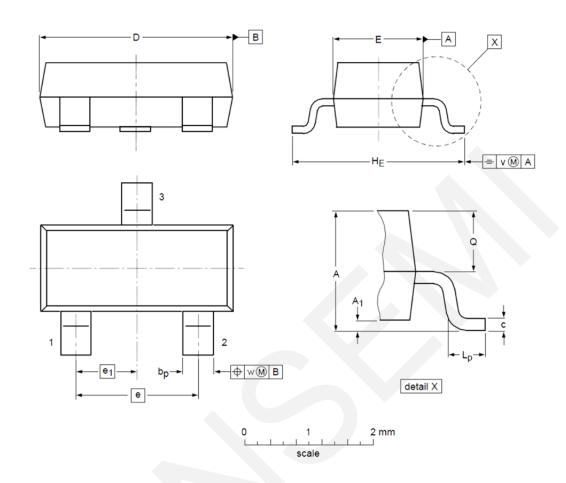
Case Temperature



Thermal Impedance, Junction-to-Case



8.Package Dimensions



DIMENSIONS (unit : mm)

Symbol	Min	Тур	Max	Symbol	Min	Тур	Max
Α	1.00	1.17	1.30	A ₁	0.01	0.05	0.10
b _P	0.35	0.39	0.50	С	0.10	0.20	0.26
D	2.70	2.90	3.10	E	1.30	1.58	1.70
е	-	1.90		e ₁		0.95	
HE	2.50	2.78	3.00	L _p	0.20	0.32	0.60
Q	0.23	0.27	0.33	v		0.20	
w	-	0.20					



9. Important Notice

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